

Notice of References Cited	Application/Control No. 09/315,068	Applicant(s)/Patent Under Reexamination HAYAKAWA ET AL.	
	Examiner Jeffrey N Zahn <i>6/2/2002</i>	Art Unit 2828	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,574,743	11-1996	van der Poel et al.	372/45
	B	US-5,892,785	04-1999	Nagai, Yutaka	257/192
	C	US-5,920,586	07-1999	Nagai, Yutaka	372/45
	D	US-6,127,691	10-2000	Fukunaga et al.	257/17
	E	US-6,181,721	01-2001	Geels et al.	257/191
	F	US-6,195,373	02-2001	Fukunaga, Toshiaki	372/45
	G	US-2002/0044584	10-2001	Fukunaga, Toshiaki	372/46
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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